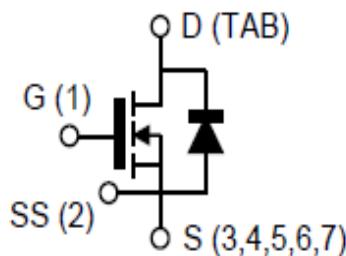


**Silicon Carbide Power MOSFET (N-Channel Enhancement)**

$V_{DS}$	650V
$I_D (25^\circ C)$	32A
$R_{DS(on)}$	100mΩ

**Features**

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free,

**Typical Applications**

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

**Mechanical Data**

- **Package:** TO-263-7L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

**■Maximum Ratings ( $T_c=25^\circ C$  Unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D2065100B7GH	
Drain source voltage @ $T_j=25^\circ C$	$V_{DS,max}$	V	650	$V_{GS}=0 V, I_D=100\mu A$	
Gate source voltage @ $T_j=25^\circ C$	$V_{GS,max}$	V	-10/+25	Absolute maximum values (AC f > 1Hz, duty cycle < 1%)	Note 1
Gate source voltage @ $T_j=25^\circ C$	$V_{GS,op}$	V	-5/+20	Recommended operational values	
Continuous drain current @ $T_c=25^\circ C$	$I_D$	A	32	$V_{GS}=20V, T_c=25^\circ C$	Fig.14
Continuous drain current @ $T_c=110^\circ C$			22	$V_{GS}=20V, T_c=110^\circ C$	
Pulse Drain Current	$I_{D,pulse}$	A	58.5	Limited by $t_{pw}$	Fig.15
Avalanche energy, Single Pulse	$E_{AS}$	mJ	260	$V_{DD}=75V, L=30mH$	
Power Dissipation	$P_{TOT}$	W	161	$T_c=25^\circ C, T_j = 175^\circ C$	Fig.13
Operating junction and Storage temperature range	$T_j, T_{stg}$	°C	-55 to +175		
Soldering temperature	$T_L$	°C	260	1.6mm (0.063") from case for 10s	
Mounting torque	$T_M$	Nm	1.0	M3 screw Maximum of mounting process: 3	

## ■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	V <sub>GS(th)</sub>	V	1.5	2.6	4.5	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 10mA	Fig.4, 11
Drain source breakdown voltage	V <sub>(BR)DSS</sub>	V	650			V <sub>GS</sub> =0, I <sub>D</sub> =100uA	
Zero gate voltage drain current	I <sub>DSS</sub>	uA		<1	50	V <sub>DS</sub> =650V, V <sub>GS</sub> = 0V	
				5	500	V <sub>DS</sub> =650V, V <sub>GS</sub> = 0V, T <sub>j</sub> = 175°C	
Gate source leakage current	I <sub>GSS</sub>	nA			250	V <sub>GS</sub> = 20V, V <sub>DS</sub> =0V	
Current drain source on-state resistance	R <sub>DS ON</sub>	mΩ		100	130	V <sub>GS</sub> =20V, I <sub>D</sub> =12A	Fig.3, 5, 6
				130		V <sub>GS</sub> =20V, I <sub>D</sub> =12A, T <sub>j</sub> =175°C	
Transconductance	g <sub>f</sub>	S		6.7		V <sub>DS</sub> =20V, I <sub>D</sub> =12A	

## ■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C <sub>iss</sub>	pF		910		V <sub>DS</sub> =400V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C, f=1MHz, V <sub>AC</sub> = 25mV	Fig.10
Output capacitance	C <sub>oss</sub>			105			
Reverse capacitance	C <sub>rss</sub>			13			
C <sub>oss</sub> stored energy	E <sub>oss</sub>	uJ		10		V <sub>DS</sub> =400V, V <sub>GS</sub> =-5/20V, I <sub>D</sub> =12A	Fig.12
Gate source charge	Q <sub>gs</sub>	nC		13.5			
Gate drain charge	Q <sub>gd</sub>			34			
Gate charge	Q <sub>g</sub>			66			
Internal Gate Resistance	R <sub>G(int)</sub>	Ω		2.0	5.0	f=1MHz, V <sub>AC</sub> = 25mV	

## ■ Switching Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on delay time	t <sub>d(on)</sub>	ns		5		V <sub>DD</sub> =400V, V <sub>GS</sub> =-5/+20V, I <sub>D</sub> =12A, L=100uH, R <sub>G(ext)</sub> = 2.7Ω	Fig.17, 18
Rise time	t <sub>r</sub>			13			
Turn off delay time	t <sub>d(off)</sub>			15			
Fall time	t <sub>f</sub>			10			
Turn on switching energy	E <sub>on</sub>	uJ		51		V <sub>DD</sub> =400V, V <sub>GS</sub> =-5/+20V, I <sub>D</sub> =12A, L=100uH, R <sub>G(ext)</sub> = 2.7Ω	Fig.17, 18
Turn off switching energy	E <sub>off</sub>			8			

■ **Body diode characteristics** (T<sub>c</sub>=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	V <sub>SD</sub>	V		4.1		V <sub>GS</sub> =0V, I <sub>SD</sub> =6A	Fig.8
Continuous diode forward current	I <sub>s</sub>	A		26.5		V <sub>GS</sub> =0V, T <sub>c</sub> =25°C	
Reverse recovery time	t <sub>rr</sub>	nS		54		V <sub>DS</sub> =400V, V <sub>GS</sub> =0V, I <sub>SD</sub> =6A, di/dt=300A/uS	
Reverse recovery charge	Q <sub>rr</sub>	nC		72			
Peak reverse recovery current	I <sub>rrm</sub>	A		2.57			

Note 1: When using SiC Body Diode the maximum recommended V<sub>GS</sub> = -5V

■ **Thermal Characteristics** (T<sub>a</sub>=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	R <sub>θJ-C</sub>	°C /W	0.93

■ **Typical Characteristics**

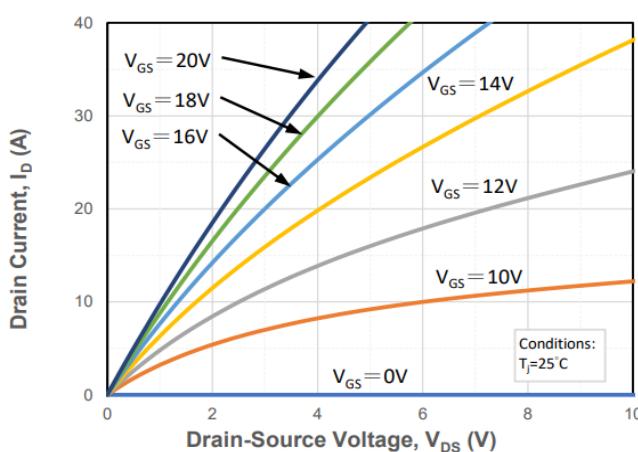


Figure 1. Output Characteristics T<sub>j</sub> = 25°C

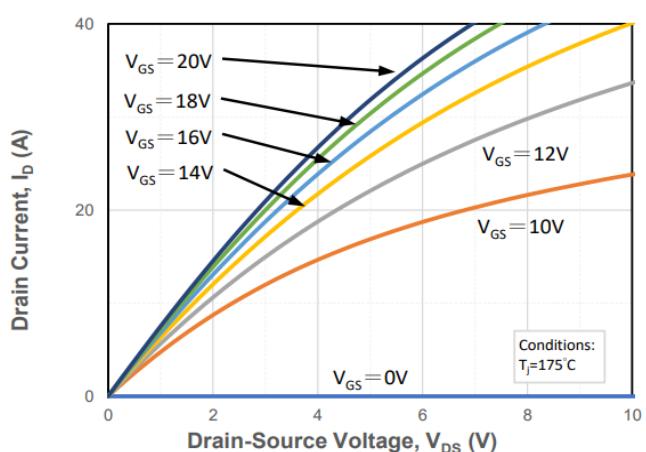


Figure 2. Output Characteristics T<sub>j</sub> = 175°C

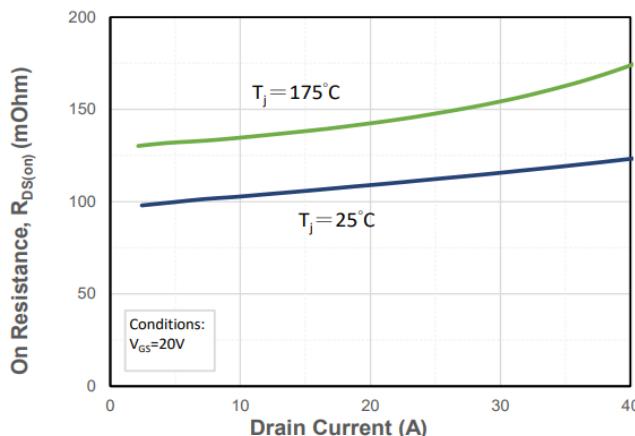


Figure 3. On-resistance vs. drain current

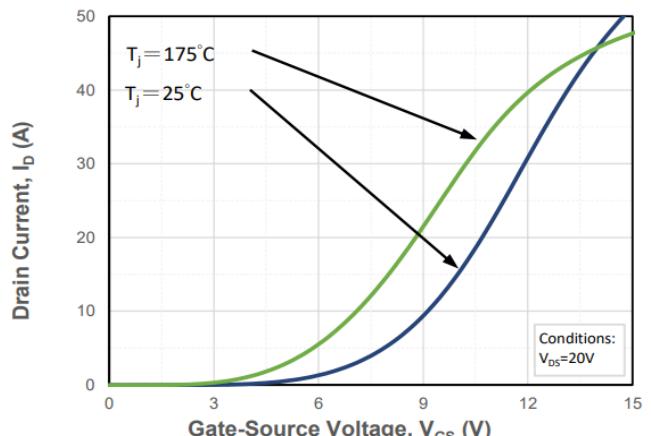
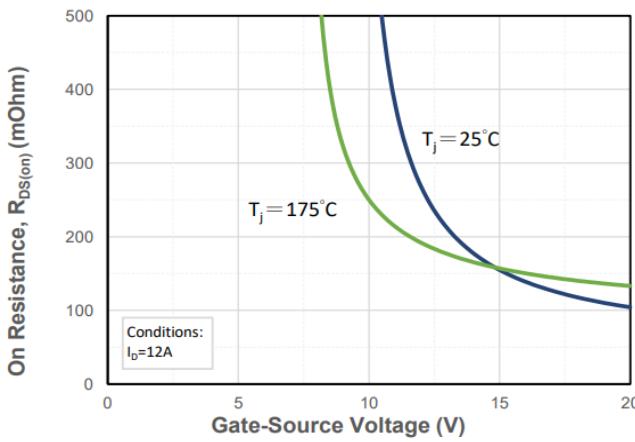
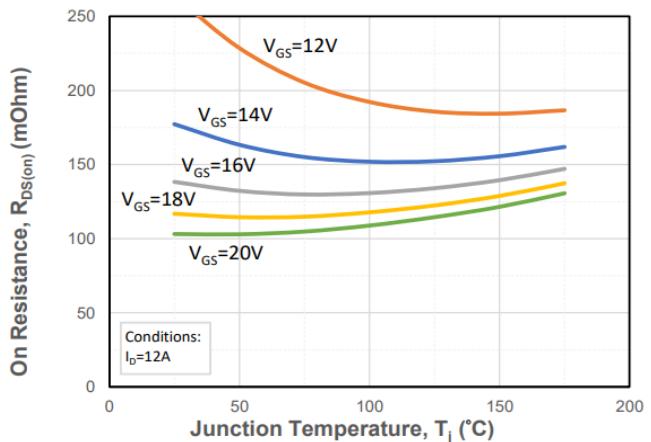
Figure 4. Transfer Characteristics for various  $T_j$ Figure 5. On-resistance vs. gate voltage for various  $T_j$ 

Figure 6. On-resistance vs. Temperature for various Gate voltage

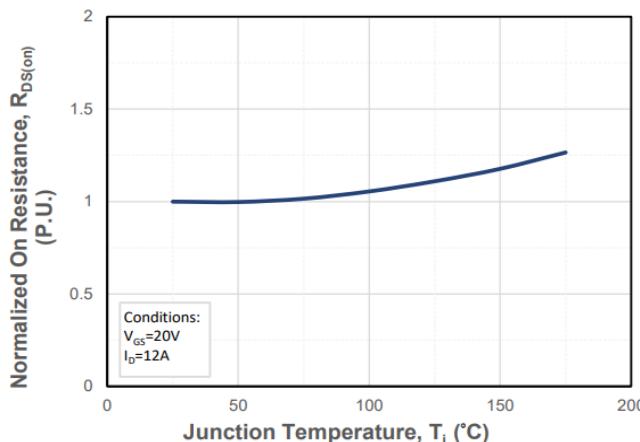
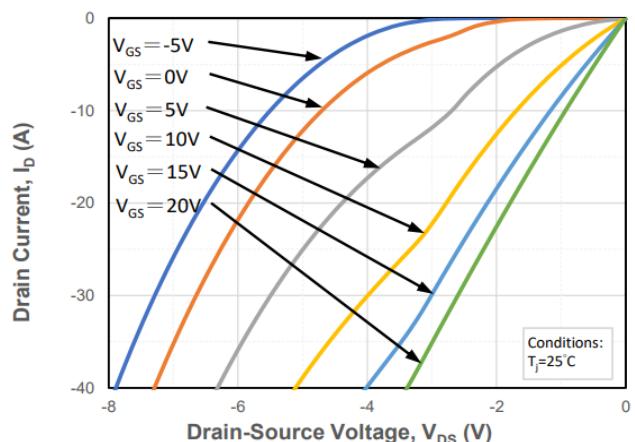
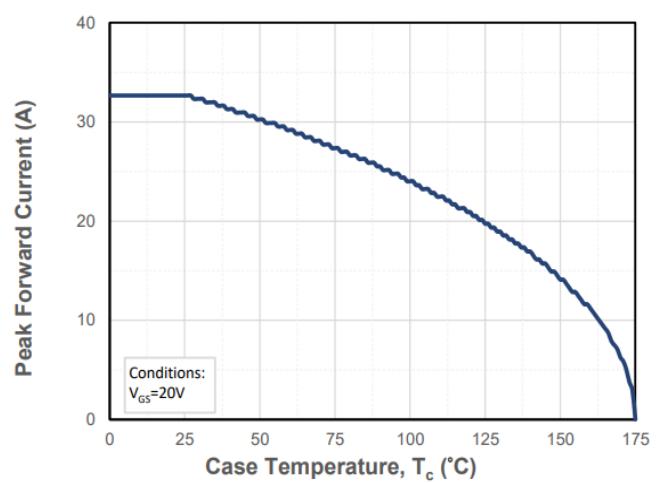
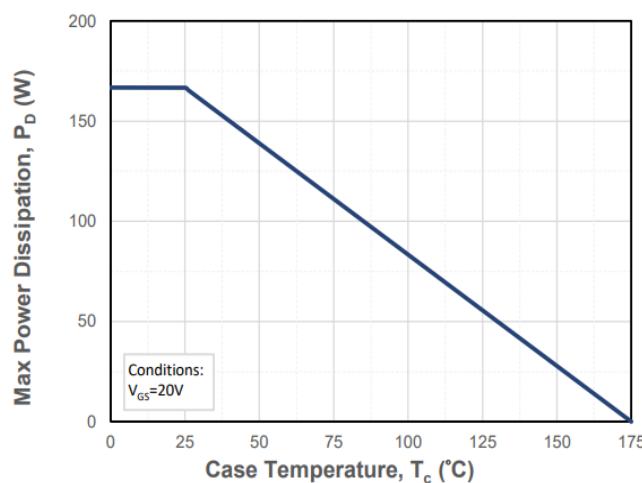
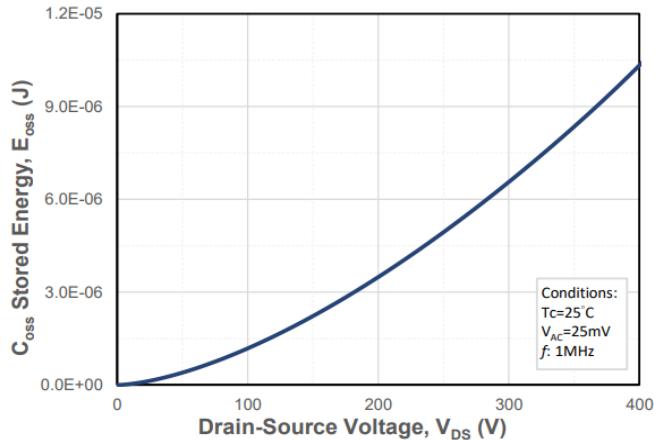
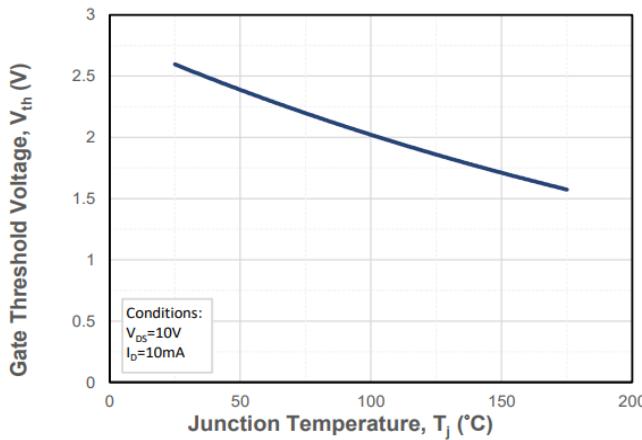
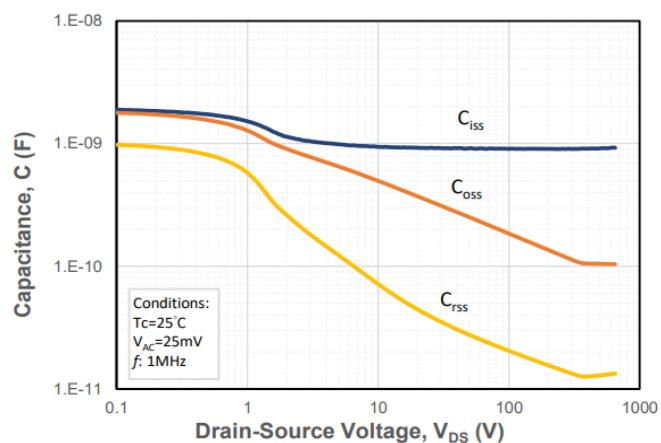
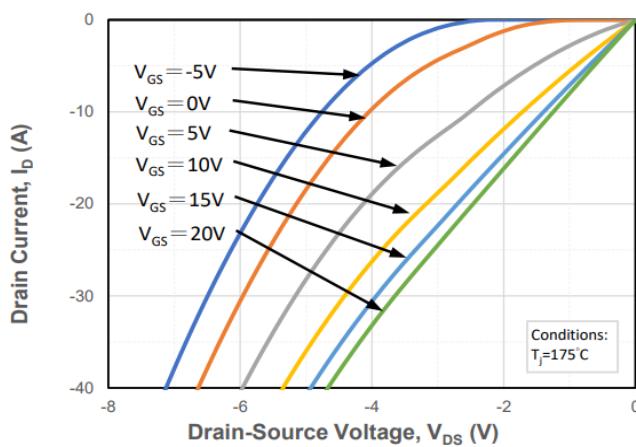


Figure 7. Normalized On-Resistance vs. Temperature

Figure 8. Reverse Output Characteristics at  $T_j = 25^\circ\text{C}$



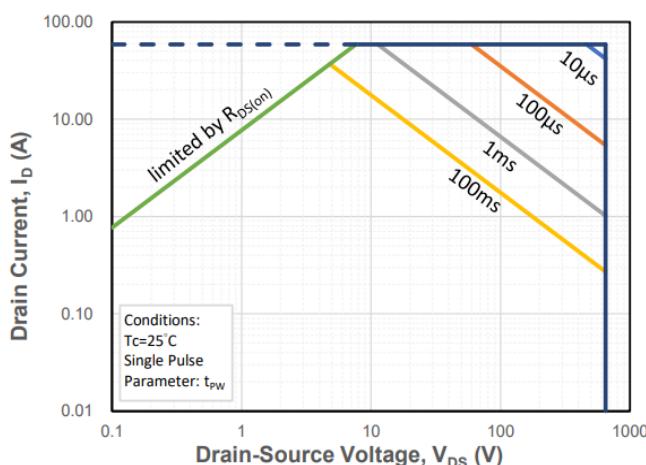


Figure 15. Safe Operating Area

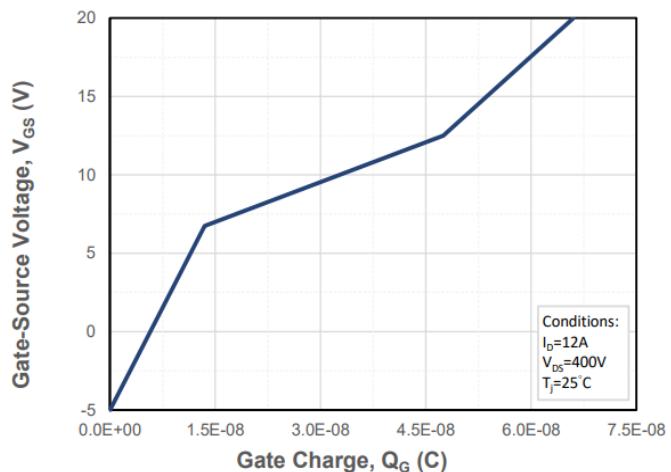


Figure 16. Gate Charge Characteristics

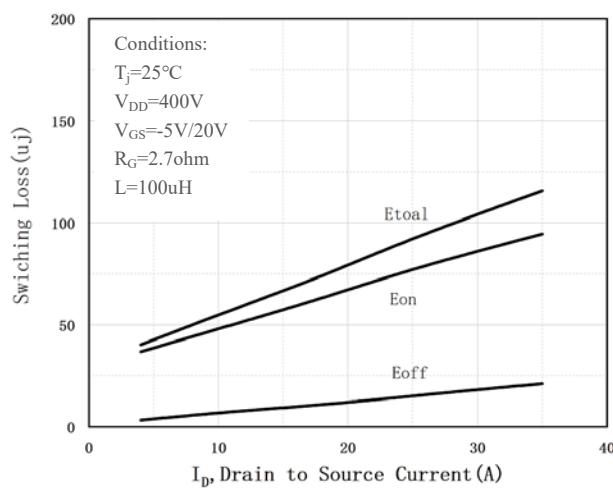


Figure 17. Clamped Inductive Switching Energy vs. Drain Current

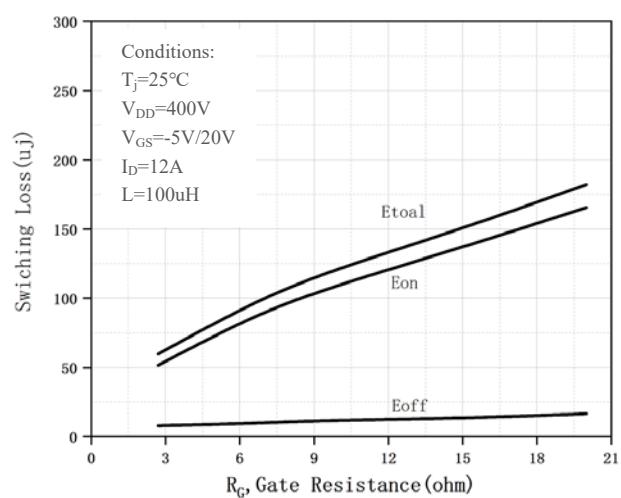


Figure 18. Clamped Inductive Switching Energy vs. External Gate Resistor ( $R_G(\text{ext.})$ )

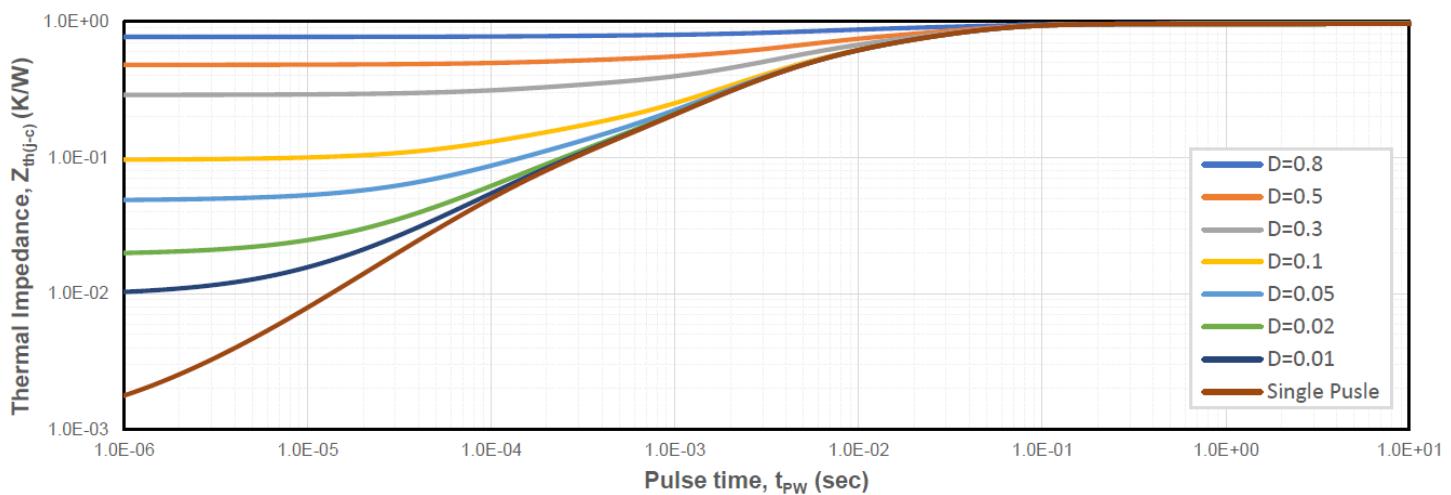


Figure 19. Transient Junction to Case Thermal Impedance

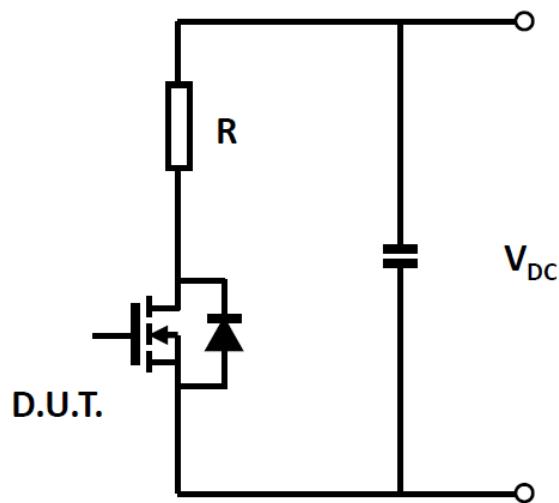


Figure 20. Schematic of Resistive Switching

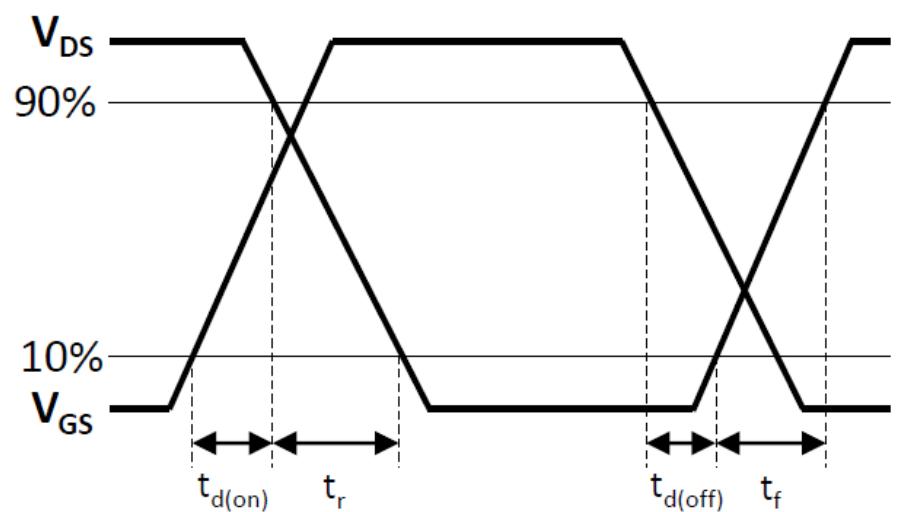
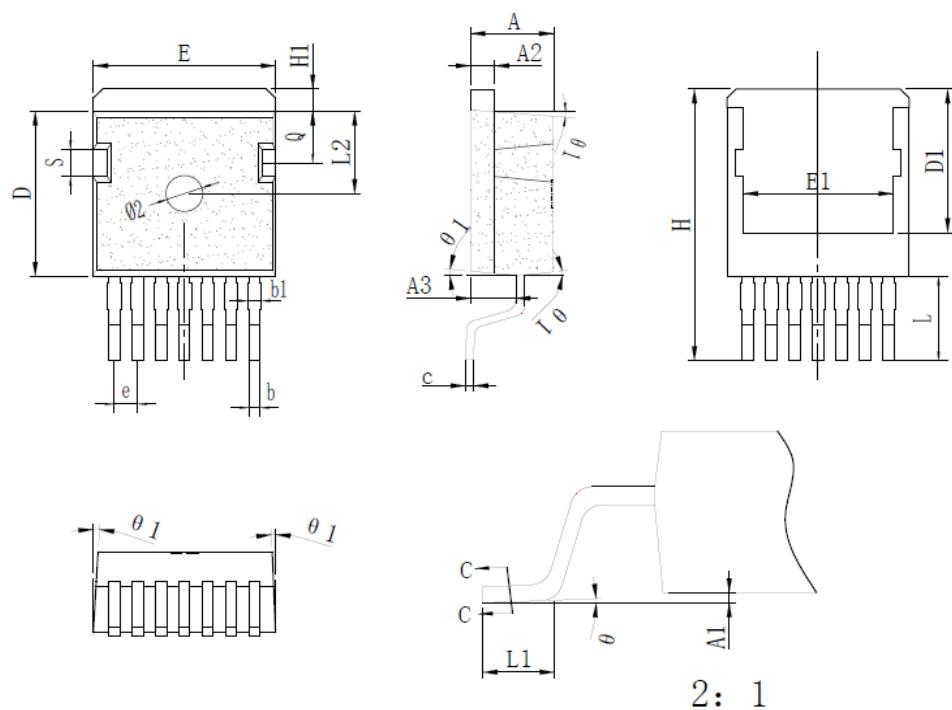
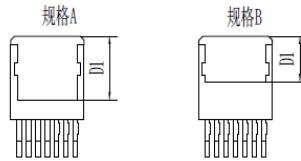


Figure 21. Switching Times Definition

## ■Outline Dimensions



\*为关键管控尺寸



SYMBOL	mm		
	MIN	NOM	MAX
*A	4.30	4.40	4.50
*A1	0.00	0.10	0.20
*A2	1.22	1.27	1.32
*A3	2.30	2.40	2.50
*b	0.50	0.60	0.70
*b1	-	-	0.63
*c	0.45	0.50	0.55
*D	9.15	9.30	9.45
D1	規格A: 8.00REF 規格B: 5.70REF		
*E	10.12	10.16	10.20
E1	8.20	8.40	8.60
*e	1.25	1.27	1.29
*H	14.85	15.00	15.15
H1	1.10	1.20	1.30
*L	4.50	4.70	4.90
L1	1.70	2.00	2.30
L2	4.55	4.65	4.75
S	1.40	1.50	1.60
Q	2.80	2.90	3.00
*θ	0°	2.5°	8°
θ1	5°	7°	9°

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